

## **MMBT2907**

Discrete POWER & Signal

**Technologies** 



## **PNP General Purpose Amplifier**

This device is designed for use as general purpose amplifiers and switches requiring collector currents to 500 mA. Sourced from Process 63. See PN2907A for characteristics.

#### **Absolute Maximum Ratings\*** TA = 25°C unless otherwise noted

Symbol	Parameter	Value	Units
V <sub>CEO</sub>	Collector-Emitter Voltage	40	V
V <sub>CBO</sub>	Collector-Base Voltage	60	V
V <sub>EBO</sub>	Emitter-Base Voltage	5.0	V
I <sub>C</sub>	Collector Current - Continuous	800	mA
T <sub>J</sub> , T <sub>stg</sub>	Operating and Storage Junction Temperature Range	-55 to +150	°C

\*These ratings are limiting values above which the serviceability of any semiconductor device may be impaired.

### NOTES:

1) These ratings are based on a maximum junction temperature of 150 degrees C.
 2) These are steady state limits. The factory should be consulted on applications involving pulsed or low duty cycle operations.

### Thermal Characteristics

TA = 25°C unless otherwise noted

Symbol	Characteristic	Мах		Units
		PN2907	*MMBT2907	
P <sub>D</sub>	Total Device Dissipation Derate above 25°C	625 5.0	350 2.8	mW mW/°C
$R_{\theta_{JC}}$	Thermal Resistance, Junction to Case	83.3		°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	200	357	°C/W

\*Device mounted on FR-4 PCB 1.6" X 1.6" X 0.06."

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# PNP General Purpose Amplifier (continued)

Symbol	Parameter	Test Conditions	Min	Мах	Units
			1		1
	RACTERISTICS	-			
V <sub>(BR)CEO</sub>	Collector-Emitter Breakdown Voltage*	$I_{\rm C} = 10 \text{ mA}, I_{\rm B} = 0$	40		V
V <sub>(BR)CBO</sub>	Collector-Base Breakdown Voltage	$I_{\rm C} = 10 \ \mu {\rm A}, \ I_{\rm E} = 0$	60		V
V <sub>(BR)EBO</sub>	Emitter-Base Breakdown Voltage	$I_{E} = 10 \ \mu A, I_{C} = 0$	5.0		V
I <sub>CEX</sub>	Collector Cutoff Current	V <sub>CE</sub> = 30 V		50	nA
В	Base Cutoff Current	V <sub>BE</sub> = 0.5 V		50	nA
Сво	Collector Cutoff Current	$V_{CB} = 50 \text{ V}, I_E = 0$ $V_{CB} = 50 \text{ V}, I_E = 0, T_A = 150 ^{\circ}\text{C}$		20 20	nA μA
ON CHAF	ACTERISTICS*				
h <sub>FE</sub>	DC Current Gain	$V_{CE} = 10 \text{ V}, \text{ I}_{C} = 0.1 \text{ mA}$ $V_{CE} = 10 \text{ V}, \text{ I}_{C} = 1.0 \text{ mA}$	35 50		
		$V_{CE} = 10 \text{ V}, I_C = 1.0 \text{ mA}$ $V_{CE} = 10 \text{ V}, I_C = 10 \text{ mA}$	50 75		
		$V_{CE} = 10 \text{ V}, I_C = 150 \text{ mA}$	100	300	
		$V_{CE} = 10 \text{ V}, \text{ I}_{C} = 500 \text{ mA}$	30	0.4	V
N /	Collector Emitter Seturation Voltage				
V <sub>CE(sat)</sub>	Collector-Emitter Saturation Voltage	$I_{\rm C} = 150 \text{ mA}, I_{\rm B} = 15 \text{ mA}$ $I_{\rm C} = 500 \text{ mA}, I_{\rm B} = 50 \text{ mA}$			
	Collector-Emitter Saturation Voltage Base-Emitter Saturation Voltage	$I_{C} = 150 \text{ mA}, I_{B} = 15 \text{ mA}$ $I_{C} = 500 \text{ mA}, I_{B} = 50 \text{ mA}$ $I_{C} = 150 \text{ mA}, I_{B} = 15 \text{ mA}$ $I_{C} = 500 \text{ mA}, I_{B} = 50 \text{ mA}$		1.6 1.3 2.6	V V V V
V <sub>BE(sat)</sub> SMALL S	Base-Emitter Saturation Voltage	$\label{eq:lc} \begin{array}{l} I_{C} = 500 \text{ mA}, I_{B} = 50 \text{ mA} \\ I_{C} = 150 \text{ mA}, I_{B} = 15 \text{ mA} \\ I_{C} = 500 \text{ mA}, I_{B} = 50 \text{ mA} \end{array}$		1.6 1.3 2.6	V V V
V <sub>BE(sat)</sub> SMALL S C <sub>ob</sub>	Base-Emitter Saturation Voltage	$\label{eq:loss} \begin{array}{l} I_{C} = 500 \text{ mA}, I_{B} = 50 \text{ mA} \\ I_{C} = 150 \text{ mA}, I_{B} = 15 \text{ mA} \\ I_{C} = 500 \text{ mA}, I_{B} = 50 \text{ mA} \end{array}$		1.6 1.3 2.6 8.0	V V V
V <sub>BE(sat)</sub> SMALL S C <sub>ob</sub> C <sub>ib</sub>	Base-Emitter Saturation Voltage	$\label{eq:loss} \begin{array}{l} I_{C} = 500 \text{ mA}, I_{B} = 50 \text{ mA} \\ I_{C} = 150 \text{ mA}, I_{B} = 15 \text{ mA} \\ I_{C} = 500 \text{ mA}, I_{B} = 50 \text{ mA} \end{array}$ $\begin{array}{l} V_{CB} = 10 \text{ V}, \text{ f} = 1.0 \text{ MHz} \\ V_{EB} = 2.0 \text{ V}, \text{ f} = 1.0 \text{ MHz} \end{array}$		1.6 1.3 2.6	V V V
V <sub>CE(sat)</sub> V <sub>BE(sat)</sub> SMALL S C <sub>ob</sub> C <sub>ib</sub> h <sub>fe</sub>	Base-Emitter Saturation Voltage	$\label{eq:loss} \begin{array}{l} I_{C} = 500 \text{ mA}, I_{B} = 50 \text{ mA} \\ I_{C} = 150 \text{ mA}, I_{B} = 15 \text{ mA} \\ I_{C} = 500 \text{ mA}, I_{B} = 50 \text{ mA} \end{array}$	2.0	1.6 1.3 2.6 8.0	V V V
V <sub>BE(sat)</sub> SMALL S C <sub>ob</sub> C <sub>ib</sub> h <sub>fe</sub>	Base-Emitter Saturation Voltage	$\begin{split} I_{C} &= 500 \text{ mA}, I_{B} = 50 \text{ mA} \\ I_{C} &= 150 \text{ mA}, I_{B} = 15 \text{ mA} \\ I_{C} &= 500 \text{ mA}, I_{B} = 50 \text{ mA} \\ \end{split}$	2.0	1.6 1.3 2.6 8.0	V V V
V <sub>BE(sat)</sub> SMALL S C <sub>ob</sub> C <sub>ib</sub> hfe SWITCHI	Base-Emitter Saturation Voltage	$\begin{split} I_{C} &= 500 \text{ mA}, I_{B} = 50 \text{ mA} \\ I_{C} &= 150 \text{ mA}, I_{B} = 15 \text{ mA} \\ I_{C} &= 500 \text{ mA}, I_{B} = 50 \text{ mA} \\ \end{split}$	2.0	1.6 1.3 2.6 8.0	V V V
V <sub>BE(sat)</sub> SMALL S C <sub>ob</sub> C <sub>ib</sub> D <sub>f</sub> re SWITCHI	Base-Emitter Saturation Voltage IGNAL CHARACTERISTICS Output Capacitance Input Capacitance Small-Signal Current Gain NG CHARACTERISTICS Turn-on Time	$\begin{split} I_{C} &= 500 \text{ mA}, I_{B} = 50 \text{ mA} \\ I_{C} &= 150 \text{ mA}, I_{B} = 15 \text{ mA} \\ I_{C} &= 500 \text{ mA}, I_{B} = 50 \text{ mA} \\ \end{split}$	2.0	1.6 1.3 2.6 8.0 30	V V V PF pF
VBE(Sat) SMALL S Cob Cib Dife SWITCHI	Base-Emitter Saturation Voltage IGNAL CHARACTERISTICS Output Capacitance Input Capacitance Small-Signal Current Gain NG CHARACTERISTICS	$\begin{array}{l} I_{C} = 500 \text{ mA}, I_{B} = 50 \text{ mA} \\ I_{C} = 150 \text{ mA}, I_{B} = 15 \text{ mA} \\ I_{C} = 500 \text{ mA}, I_{B} = 50 \text{ mA} \\ \end{array}$	2.0	1.6 1.3 2.6 8.0 30 45	PF pF ns
V <sub>BE(sat)</sub> SMALL S C <sub>ob</sub> C <sub>ib</sub> hfe SWITCHI ton tr	Base-Emitter Saturation Voltage IGNAL CHARACTERISTICS Output Capacitance Input Capacitance Small-Signal Current Gain NG CHARACTERISTICS Turn-on Time Delay Time	$\begin{split} & I_{C} = 500 \text{ mA}, I_{B} = 50 \text{ mA} \\ & I_{C} = 150 \text{ mA}, I_{B} = 15 \text{ mA} \\ & I_{C} = 500 \text{ mA}, I_{B} = 50 \text{ mA} \\ \end{split} \\ & V_{CB} = 10 \text{ V}, \text{ f} = 1.0 \text{ MHz} \\ & V_{EB} = 2.0 \text{ V}, \text{ f} = 1.0 \text{ MHz} \\ & I_{C} = 50 \text{ mA}, V_{CE} = 20 \text{ V}, \\ & \text{f} = 100 \text{ MHz} \\ \end{split}$	2.0	1.6 1.3 2.6 8.0 30 45 10	PF pF ns ns
V <sub>BE(sat)</sub> SMALL S C <sub>ob</sub> C <sub>ib</sub> h <sub>fe</sub>	Base-Emitter Saturation Voltage IGNAL CHARACTERISTICS Output Capacitance Input Capacitance Small-Signal Current Gain NG CHARACTERISTICS Turn-on Time Delay Time Rise Time	$\begin{split} I_{C} &= 500 \text{ mA}, I_{B} = 50 \text{ mA} \\ I_{C} &= 150 \text{ mA}, I_{B} = 15 \text{ mA} \\ I_{C} &= 500 \text{ mA}, I_{B} = 50 \text{ mA} \\ \end{split}$	2.0	1.6 1.3 2.6 8.0 30 45 10 40	v V V V PF pF ns ns ns

PN2907 / MMBT2907

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Definition of Terms

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